

SN74LV8153-Q1 SERIAL-TO-PARALLEL INTERFACE

SCLS591A - SEPTEMBER 2004 - REVISED APRIL 2008

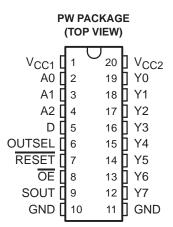
DESCRIPTION

The SN74LV8153 is a serial-to-parallel data converter. It accepts serial input data and outputs 8-bit parallel data.

The automatic data-rate detection feature of the SN74LV8153 eliminates the need for an external oscillator and helps with cost and board real-estate savings.

The OUTSEL pin is used to choose between open collector and push-pull outputs. The open-collector option is suitable when this device is used in applications such as LED interface, where high drive current is required. SOUT is the output that acknowledges reception of the serial data.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC1} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.



FEATURES

- Qualified for Automotive Applications
- Single-Wire Serial Data Input
- Compatible With UART Serial-Data Format
- Up to Eight Devices (64-Bit Parallel) Can Share the Same Bus by Using Different Combinations of A0, A1, A2
- Up to 40 mA Current Drive in Open-Collector Mode for Driving LEDs
- Outputs Can be Configured as Open-Collector or Push-Pull
- Internal Oscillator and Counter for Automatic Data-Rate Detection
- Output Levels Are Referenced to V_{CC2} and Can Be Configured From 3 V to 12 V
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 1000-V Charged-Device Model (C101)

SUMMARY OF RECOMMENDED OPERATING CONDITIONS

PARAMETER	
VCC1	3 V to 5.5 V
V _{CC2}	3 V to 13.2 V
lOL	40 mA @ V _{CC2} = 4.5 V (open-collector mode)
ЮН	-24 mA @ V _{CC2} = 12 V (push-pull mode)
Maximum Data Rate	24 Kbps



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



FUNCTION TABLE (each buffer)

	INPUT	S		OUTPUT	OUTPUT
OUTSEL	L RESET OE Dn		Dn	Yn	STRUCTURE
L	Н	L	Н	L	
L	Н	L	L	Н	0
L	X	Н	X	Open collector	
L	L	Χ	Χ	Н	
Н	Н	L	Н	Н	
Н	Н	L	L	L	Duch null
Н	X	Н	X	Z	Push-pull
Н	L	L	Χ	L	

In the open-collector mode (OUTSEL = L), the outputs are inverted, e.g., Y1 = I, when D1 = H

ORDERING INFORMATION†

TA			PACKAGE [‡]		ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 125	°C	TSSOP - PW		Tape and reel	SN74LV8153QPWRQ1	LV8153Q

[†] For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at http://www.ti.com.

PIN DESCRIPTION

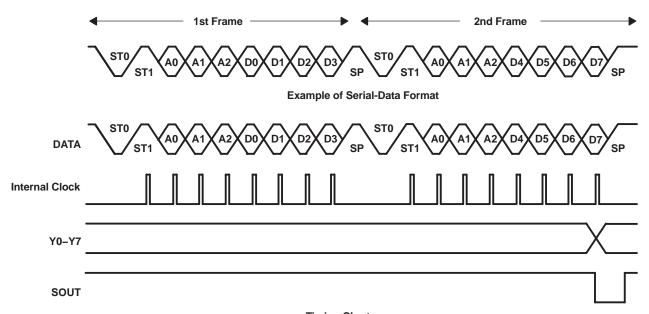
PIN#	PIN NAME	I/O	PIN FUNCTION
1	V _{CC1}		Power-supply pin (all inputs and outputs except for Y0-Y7)
2-4	A0, A1, A2	In	The address pins are used to program the address of the device and allow up to eight devices to share the same bus.
5	D	In	Serial data input
6	OUTSEL	In	Choose between open-collector and push-pull type outputs (Y0-Y7).
7	RESET	In	Initialize register status
8	ŌĒ	In	Force Y0-Y7 to Hi-Z
9	SOUT	Out	Outputs a pulse when latch data is changed. Supplied by V _{CC1} .
12-19	Y0-Y7	Out	Push-pull or open collector parallel data outputs. Supplied by V _{CC2} .
20	V _{CC2}		Power-supply pin for outputs (Y0-Y7). V _{CC2} can range from 3 V to 13.2 V.

 $^{\ ^{\}ddagger} \ \mathsf{Package} \ \mathsf{drawings}, \ \mathsf{thermal} \ \mathsf{data}, \ \mathsf{and} \ \mathsf{symbolization} \ \mathsf{are} \ \mathsf{available} \ \mathsf{at} \ \mathsf{http://www.ti.com/packaging}.$

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data transmission protocol

- The serial data should be sent as 2START-3ADDRESS-4DATA-1STOP. Two consecutive serial-data frames transmit 8 bits of data. The first frame includes the lower four bits of data (D0-D3), and the second frame includes the upper four bits (D4-D7).
- The three address bits (in the consecutive frame) must be the same as those in the first frame;
 otherwise, the data will be dropped.
- The order of the two start bits must be 0, then 1 in any frame; otherwise, the data rate will not be detected correctly. The period between the falling edge of the first start bit (ST0) and the rising edge of the second start bit (ST1) is measured to generate an internal-clock synchronized data stream.



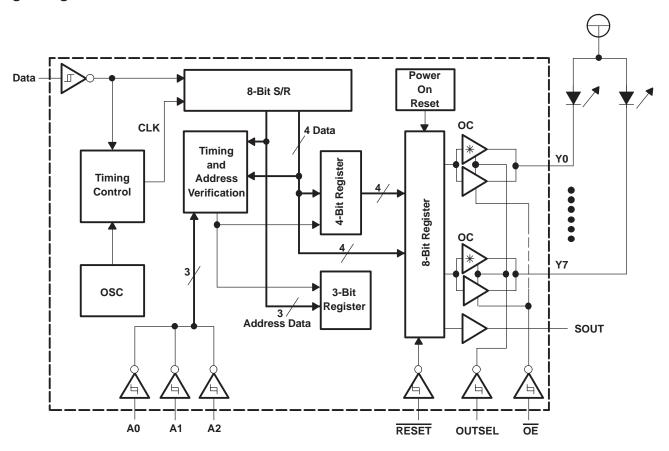
Timing Chart

⁽¹⁾Internal clock cannot be observed.

⁽¹⁾D0 is LSB and D7 is MSB. The data stream should be LSB first.



logic diagram



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)(1)

Supply voltage range, V _{CC1}	–0.5 V to 7 V
Supply voltage range, V _{CC2}	
Input voltage range, V _I ⁽²⁾	
Voltage range applied to any output in the high or low state, V _O (SOUT) ⁽²⁾⁽³⁾	$-0.5 \text{ V to V}_{CC1} + 0.5 \text{ V}$
Voltage range applied to any output in the high-impedance	
or power-off state, V _O (SOUT) ⁽²⁾	
Voltage range, applied to any output in the high or low state, V _O (Y0-Y7) ⁽²⁾ (3)	$-0.5 \text{ V to V}_{CC2} + 0.5 \text{ V}$
Voltage range applied to any output in the high-impedance	
or power-off state, V _O (Y0-Y7) ⁽²⁾	
Input clamp current, I _{IK} (V _I < 0)	
Output clamp current, I _{OK} (V _O < 0)	–50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	
Continuous current, I _O (OUTSEL = L, Y0-Y7 = L)	
Package thermal impedance, $\theta_{JA}^{(4)}$	
Storage temperature range, T _{stg}	–65°C to 150°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

⁽²⁾ The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

⁽³⁾ The value of V_{CC} is provided in the recommended operating condition table.

⁽⁴⁾The package thermal impedance is calculated in accordance with JESD 51-7.



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recommended operating conditions (1)

				V _{CC1}	V _{CC2}	MIN	MAX	UNIT		
VCC1	Supply voltage					3	5.5	V		
V _{CC2}	Supply voltage					3	13.2	V		
.,			3 V	3 V	V _{CC} ×0.7		.,			
VIH	High-level input voltage			4.5 V	4.5 V	V _{CC} ×0.7		V		
.,	Law law d Sanatas Rawa			3 V	3 V		$V_{CC} \times 0.3$.,		
V_{IL}	Low-level input voltage			4.5 V	4.5 V		$V_{CC} \times 0.3$	V		
٧ _I	Input voltage					0	5.5	V		
.,	0			4.5 V	4.5 V	0	5.5	.,		
VO	V _O Output voltage				12 V	0	13.2	V		
						3 V	3 V		-2	
		Yn	OUTSEL = H	4.5 V	4.5 V		-8	mA		
loh	High-level output current			4.5 V	12 V		-24			
		00117		3 V	3 V		-4			
		SOUT		4.5 V	4.5 V		-8	mA		
			OUTOF! !!	3 V	3 V		2			
		V -	OUTSEL = H	4.5 V	4.5 V		8			
	Law law of autout autout	Yn	OLITOFI I	3 V	3 V		20			
IOL	IOL Low-level output current		OUTSEL = L	4.5 V	4.5 V		40	mA		
		COLIT		3 V	3 V		4			
		SOUT		4.5 V	4.5 V		8			
TA	Operating free-air temperature					-40	125	°C		

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMET	ER	TEST CONDITIO	V _{CC1}	V _{CC2}	MIN	TYP	MAX	UNIT	
V _{T+}			3.3 V	3.3 V			2.31		
Positive-going input voltage	tthreshold	All inputs		5 V	5 V			3.5	V
V _T _	d dhaaah alal			3.3 V	3.3 V	0.99			.,
Negative-going input voltage	it threshold	All inputs		5 V	5 V	1.5			V
ΔV _T				3.3 V	3.3 V	0.33		1.32	
Hysteresi: (V _{T+} – V _{T-}		All inputs		5 V	5 V	0.5		2	V
		I _{OH} = -2 mA		3 V	3 V	2.38			
	Yn	I _{OH} = -8 mA		4.5 V	4.5 V	3.8			
VOH		I _{OH} = -24 mA		4.5 V	12 V	11			V
_	2011	I _{OH} = -4 mA	3 V	3 V	2.38				
	SOUT	I _{OH} = -8 mA		4.5 V	4.5 V	3.8			
		I _{OL} = 2 mA (OUTSEL = H)		3 V	3 V			0.44	
	Yn	I _{OL} = 8 mA (OUTSEL = H)		4.5 V	4.5 V			0.44	
VOL		I _{OL} = 40 mA (OUTSEL = L)		4.5 V	4.5 V			0.5	V
_	2011	I _{OL} = 4 mA		3 V	3 V			0.44	
	SOUT	I _{OL} = 8 mA		4.5 V	4.5 V			0.44	
lį		V _I = 5.5 V or GND		0 to 5.5 V				±1	μА
loz		$V_O = V_{CC}$ or GND (OUTSEL	V _O = V _{CC} or GND (OUTSEL = H)		5.5 V			±5	μА
loн		V _O = 12 V (OUTSEL = L)		5.5 V	5.5 V			5	μΑ
Icc		$V_I = V_{CC}$ or GND, $I_O = 0$ OUTSEL = H OUTSEL = L		5.5 V	5.5 V			5 20	mA
I _{off} (except	SOUT)	V _I or V _O = 0 to 5.5 V, V _{CC} = 0	0	0	0			±50	μΑ
Ci	· · · · · · · · · · · · · · · · · · ·	V _I = V _{CC} or GND		5 V	5 V		5		pF

switching characteristics over recommended operating free-air temperature range, V_{CC1} = V_{CC2} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figures 1 and 2)

DADAMETED	FROM	то	LOAD	T,	4 = 25°C	;	MINI	BAAV	
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	UNIT
	D7	Υ			Pw/2	(1)			
for all	D7	SOUT]		Pw/2	(1)			
^t pd	RESET	Υ]					220	ns
	OE(2)	Y	C _L = 50 pF					220	
t _{en}	OE(3)	Υ						220	ns
^t dis	<u>OE</u> (3)	Y]					220	ns
t _W		SOUT]		Pw	(4)			ns
Data rate							2	24	Kbps

⁽¹⁾ The tpd is dependent on the data pulse width (Pw), and Y outputs are changed after one-half of Pw, because the internal clock is synchronized at the middle of the data pulse. Not tested, but specified by design.

(2) When outputs are open collector (OUTSEL = L)

⁽³⁾ When outputs are push-pull (OUTSEL = H)

⁽⁴⁾ SOUT goes low when the data is received correctly and maintains a low level for one data-pulse period. Not tested, but specified by design.





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switching characteristics over recommended operating free-air temperature range, V_{CC1} = V_{CC2} = 5 V \pm 0.5 V (unless otherwise noted) (see Figures 1 and 2)

DADAMETER	FROM	то	LOAD	T	չ = 25°C	;	MINI	MAY	LINUT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	UNIT
	D7	Υ			Pw/2	(1)			
to a	D7	SOUT			Pw/2	(1)			20
^t pd	RESET	Υ						200	ns
	OE(2)	Υ	C _L = 50 pF					200	
t _{en}	<u>OE</u> (3)	Υ						200	ns
tdis	<u>OE</u> (3)	Υ						200	ns
t _W		SOUT			Pw	(4)			ns
Data rate							2	24	Kbps

⁽¹⁾ The t_{pd} is dependent on the data pulse width (Pw), and Y outputs are changed after one-half of Pw, because the internal clock is synchronized at the middle of the data pulse. Not tested, but specified by design.

⁽²⁾ When outputs are open collector (OUTSEL = L)

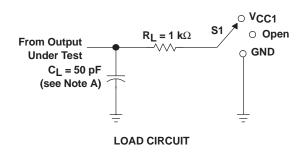
⁽³⁾ When outputs are push-pull (OUTSEL = H)

⁽⁴⁾ SOUT goes low when the data is received correctly and maintains a low level for one data-pulse period. Not tested, but specified by design.

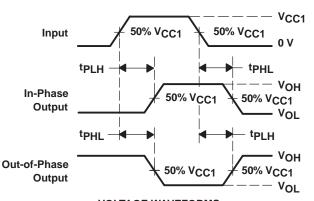


PARAMETER MEASUREMENT INFORMATION (PUSH-PULL OUTPUT)

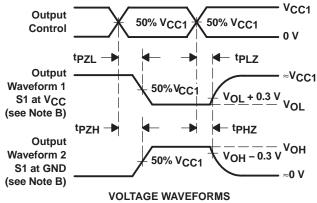
50% V_{CC1}



TEST	S 1
tPLH/tPHL	Open
tPLZ/tPZL	V _{CC1}
tPHZ/tPZH	GND



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES
INVERTING AND NONINVERTING OUTPUTS



ENABLE AND DISABLE TIMES
LOW- AND HIGH-LEVEL ENABLING

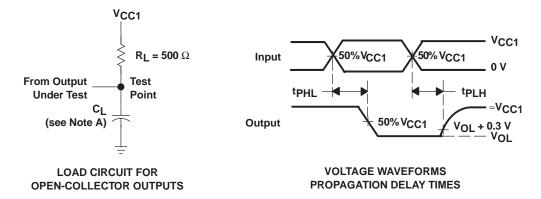
NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: $Z_Q = 50 \ \Omega$, $t_f \le 3 \ ns$, $t_f \le 3 \ ns$.
- D. The outputs are measured one at a time, with one input transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzI and tpzH are the same as ten.
- G. tpHL and tpLH are the same as tpd.
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION (OPEN-COLLECTOR OUTPUT)



NOTES: A. C_I includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_f \leq 3$ ns.
- C. The outputs are measured one at a time, with one input transition per measurement.
- D. t_{PHL} and t_{PLH} are the same as t_{pd} .

Figure 2. Load Circuit and Voltage Waveforms

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
SN74LV8153QPWRG4Q1	Active	Production	TSSOP (PW) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV8153Q
SN74LV8153QPWRG4Q1.A	Active	Production	TSSOP (PW) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV8153Q
SN74LV8153QPWRQ1	Active	Production	TSSOP (PW) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV8153Q
SN74LV8153QPWRQ1.A	Active	Production	TSSOP (PW) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV8153Q

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF SN74LV8153-Q1:

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE OPTION ADDENDUM

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Catalog : SN74LV8153

NOTE: Qualified Version Definitions:

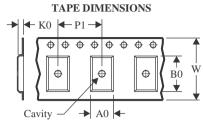
• Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

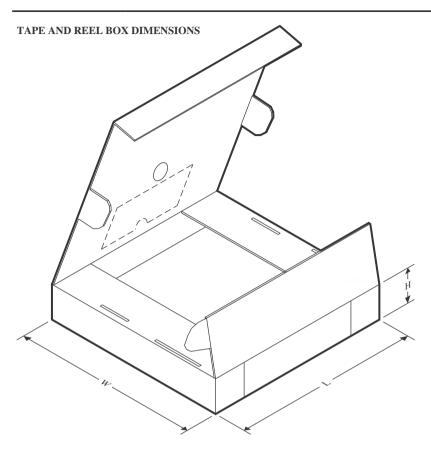
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV8153QPWRG4Q1	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74LV8153QPWRQ1	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1

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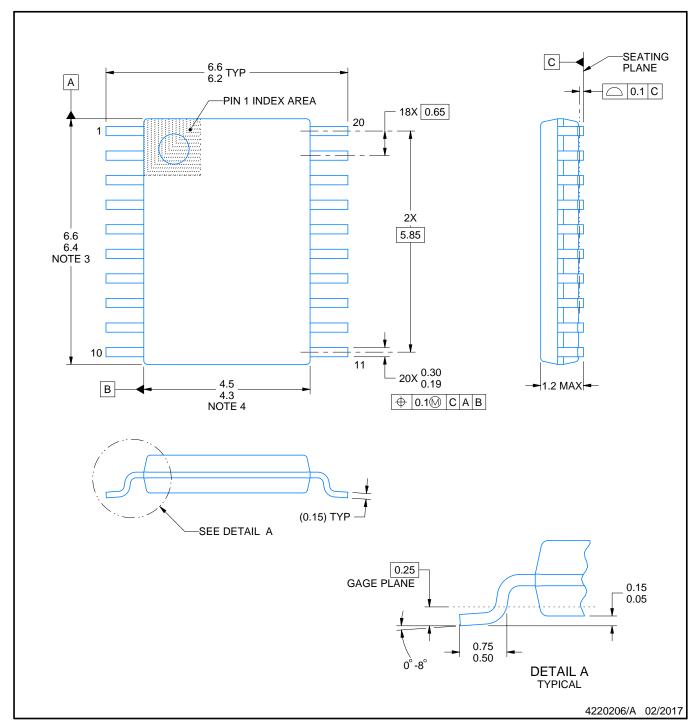


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV8153QPWRG4Q1	TSSOP	PW	20	2000	353.0	353.0	32.0
SN74LV8153QPWRQ1	TSSOP	PW	20	2000	353.0	353.0	32.0



SMALL OUTLINE PACKAGE



NOTES:

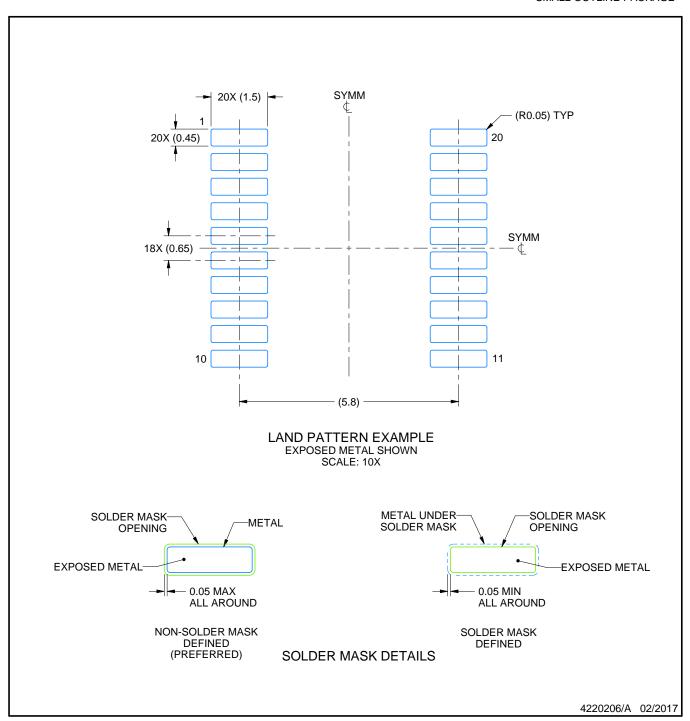
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



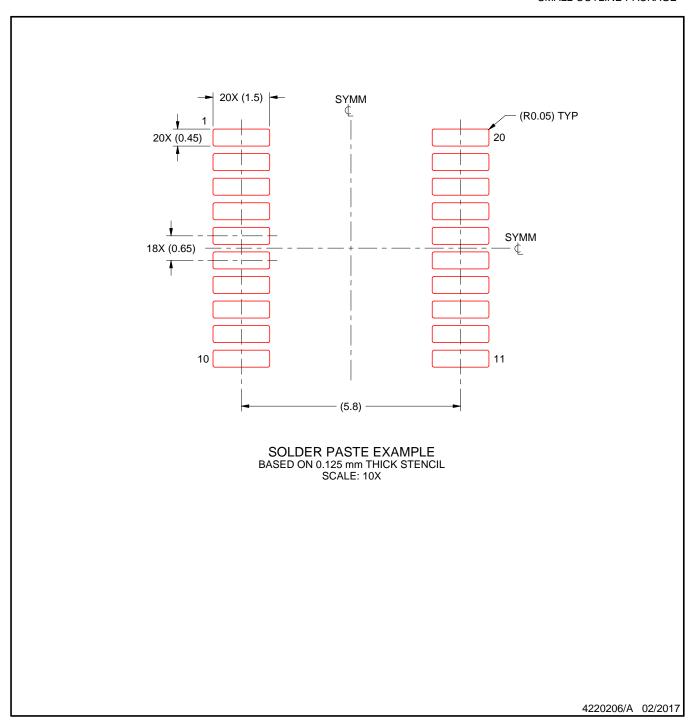
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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